

## WSP8810

**Dual N-Channel MOSFET** 

## **General Description**

The WSP8810 is the highest performance trench N-ch MOSFETs with extreme high cell density , which provide excellent RDSON and gate charge for most of the small power switching and load switch applications.

The WSP8810 meet the RoHS and Green Product requirement with full function reliability approved.

#### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

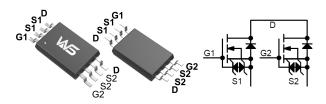
## **Product Summery**

BVDSS	RDSON ID	
20V	11.5mΩ	7.5A

## Applications

- High Frequency Point-of-Load Synchronous Small power switching for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- ESD:2KV

### **TSSOP-8** Pin Configuration



## **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage	20	V	
V <sub>GS</sub>	Gate-Source Voltage	±12	V	
I <sub>D</sub> @T <sub>c</sub> =25℃	Continuous Drain Current, $V_{GS} @ 4.5V^1$ 7.5		А	
I <sub>D</sub> @T₀=70℃	Continuous Drain Current, V <sub>GS</sub> @ 4.5V <sup>1</sup>	6	А	
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	30	А	
P <sub>D</sub> @T <sub>A</sub> =25℃	Total Power Dissipation <sup>3</sup> 1.25		W	
T <sub>STG</sub>	Storage Temperature Range -55 to 150		°C	
TJ	Operating Junction Temperature Range -55 to 150		°C	

## Thermal Data

Symbol	Parameter	Тур.	Typ. Max.	
R <sub>eja</sub>	Thermal Resistance Junction-ambient <sup>1</sup>		100	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		70	°C/W



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## Electrical Characteristics (T<sub>J</sub>=25<sup>-1</sup>C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	20			V
$\triangle BV_{DSS} / \triangle T_J$	BVDSS Temperature Coefficient	Reference to 25 $^\circ\!\mathrm{C}$ , I_D=1mA		0.022		V/℃
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =7.5A		11.5	14.5	mΩ
		V <sub>GS</sub> =2.5V , I <sub>D</sub> =5A		14.5	20	
V <sub>GS(th)</sub>	Gate Threshold Voltage		0.5	0.7	1.0	V
	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_{D}=250$ uA		-2.33		mV/℃
	Drain-Source Leakage Current	V <sub>DS</sub> =16V , V <sub>GS</sub> =0V , T <sub>J</sub> =25℃			1	
I <sub>DSS</sub>		V <sub>DS</sub> =16V , V <sub>GS</sub> =0V , T <sub>J</sub> =55℃			5	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}=\pm 12V$ , $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =5A		36		S
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		4		Ω
Qg	Total Gate Charge (4.5V)	V <sub>DS</sub> =10V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =7.5A		13.5	18	
Q <sub>gs</sub>	Gate-Source Charge			1.5		nC
Q <sub>gd</sub>	Gate-Drain Charge			5.8		
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> =10V , V <sub>GS</sub> =4.5V , R <sub>G</sub> =3.3Ω I <sub>D</sub> =5A		10.8	20	
Tr	Rise Time			14.5	26	
T <sub>d(off)</sub>	Turn-Off Delay Time			51	55	ns
T <sub>f</sub>	Fall Time			45	81	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =10V , V <sub>GS</sub> =0V , f=1MHz		900		
C <sub>oss</sub>	Output Capacitance			175		pF
Crss	Reverse Transfer Capacitance			160		

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current <sup>1,4</sup>	$V_G = V_D = 0V$ , Force Current			1.5	А
I <sub>SM</sub>	Pulsed Source Current <sup>2,4</sup>				30	А
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25℃		0.7	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	lF=7.5A,dl/dt=100A/μs , Tյ=25℃		13.5		nS
Qrr	Reverse Recovery Charge			4		nC

Note :

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper, t $\leq$ 10sec.

2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2% 3. The power dissipation is limited by 150 °C junction temperature

4. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



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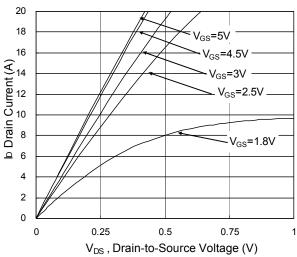


Fig.1 Typical Output Characteristics

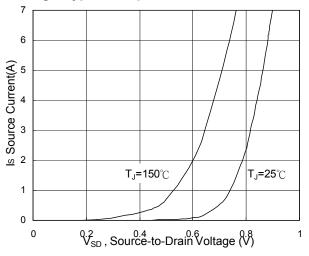


Fig.3 Forward Characteristics Of Reverse

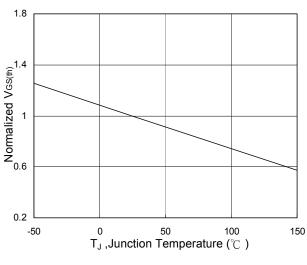


Fig.5 Normalized  $V_{GS(th)}$  vs. T<sub>J</sub>

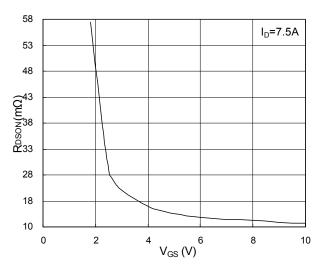


Fig.2 On-Resistance vs. Gate-Source

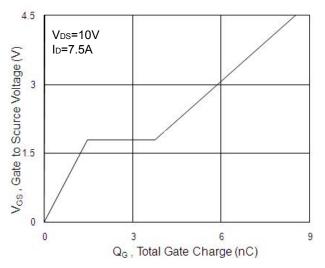


Fig.4 Gate-Charge Characteristics

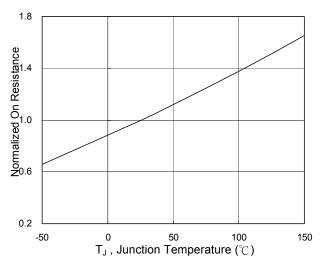
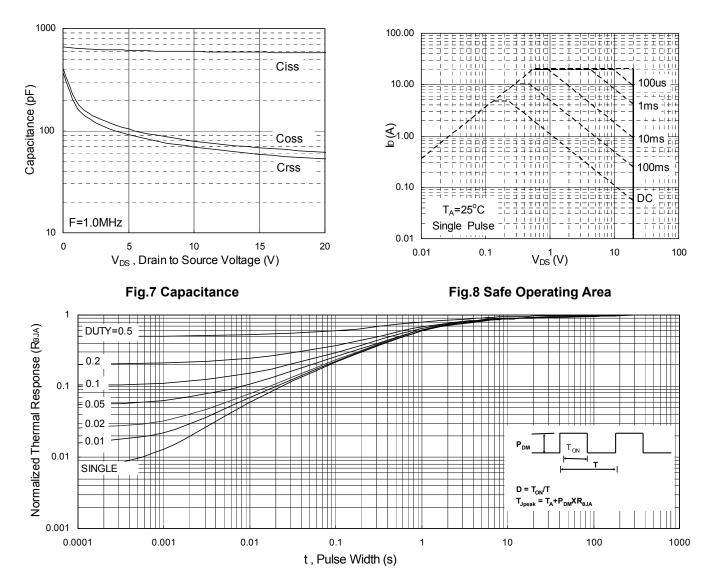


Fig.6 Normalized  $R_{\text{DSON}}$  vs.  $T_{\text{J}}$ 

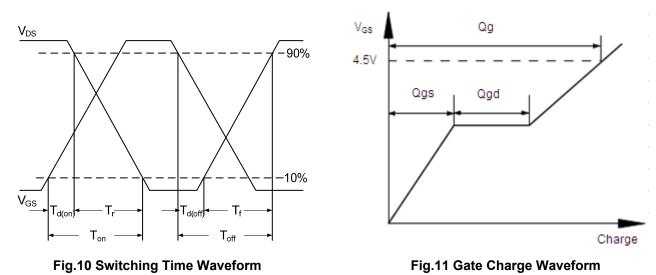


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